



60V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on) max}	I _D T _A = 25°C
001/	$44m\Omega @ V_{GS} = 10V$	5.0A
60V	$60m\Omega @ V_{GS} = 4.5V$	4.3A

Description and Applications

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

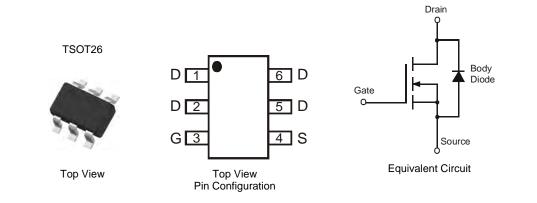
- DC-DC Converters
- Power management functions
- Backlighting

Features and Benefits

- 100% Unclamped Inductive Switch (UIS) test in production
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Lead, Halogen, and Antimony Free, RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.013 grams (approximate)



Ordering Information (Note 3)

Part Number	Case	Packaging	
DMN6040SVT-7	TSOT26	3,000/Tape & Reel	

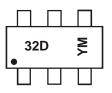
1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. No purposely added lead. Halogen and Antimony free.

2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com.

3. For packaging details, go to our website at http://www.diodes.com.

Marking Information

Notes:



32D = Product Type Marking Code YM = Date Code Marking Y = Year (ex: X = 2010) M = Month (ex: 9 = September)

Date Code Key													
Year	201	0	2011		2012	20	13	2014		2015	2	2016	
Code	Х		Y		Z		A			С		D	
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec	
Code	1	2	3	4	5	6	7	8	9	0	N	D	

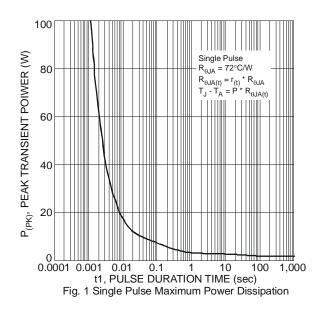


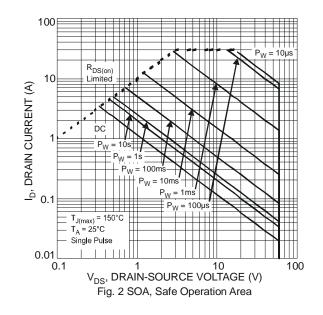
Maximum Ratings @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units V V		
Drain-Source Voltage	V _{DSS}	60			
Gate-Source Voltage	V _{GSS}	±20			
	Steady State	T _A = 25°C T _A = 70°C	I _D	5.0 4.0	А
Continuous Drain Current (Note 5) $V_{GS} = 10V$	t<10s	$T_A = 25^{\circ}C$ $T_A = 70^{\circ}C$	I _D	6.3 5.0	А
	Steady State	$T_A = 25^{\circ}C$ $T_A = 70^{\circ}C$	۱ _D	4.3 3.4	А
Continuous Drain Current (Note 5) $V_{GS} = 5V$	t<10s	T _A = 25°C T _A = 70°C	ID	5.4 4.3	A
Maximum Body Diode Forward Current (Note 5)	•	IS	2.1	А	
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	30	А		
Avalanche Current (Note 6) L = 0.1mH	I _{AR}	14.2	А		
Avalanche Energy (Note 6) L = 0.1mH	E _{AR}	10	mJ		

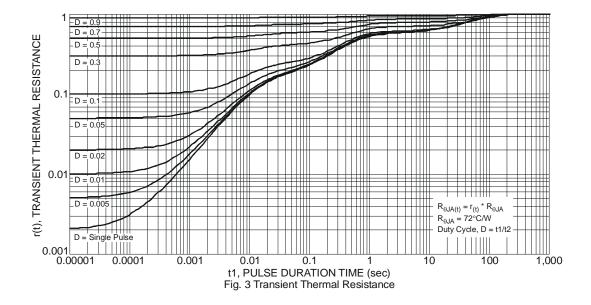
Thermal Characteristics $@T_A = 25^{\circ}C$ unless otherwise specified

Characteristic		Symbol	Value	Units
Total Dowar Dissinction (Note 4)	$T_A = 25^{\circ}C$	D	1.2	W
Total Power Dissipation (Note 4)	T _A = 70°C	PD	0.75	vv
Thermal Registeres, Junction to Ambient (Note 4)	Steady state	D	106	°C/W
Thermal Resistance, Junction to Ambient (Note 4)	t<10s	$R_{ ext{ heta}JA}$	69	°C/W
Total Power Dissipation (Note 5)	$T_A = 25^{\circ}C$	Р	1.8	W
Total Power Dissipation (Note 5)	$T_A = 70^{\circ}C$	PD	1.1	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	D	68	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{ ext{ heta}JA}$	44	°C/W
Thermal Resistance, Junction to Case (Note 5)		$R_{\theta JC}$	20	°C/W
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C









Electrical Characteristics @T_A = 25°C unless otherwise specified

			-				
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)			1		i	1	
Drain-Source Breakdown Voltage	BV _{DSS}	60	—	—	V	$V_{GS} = 0V, I_D = 250 \mu A$	
Zero Gate Voltage Drain Current	I _{DSS}			100	nA	$V_{DS} = 60V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	—	—	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)			÷				
Gate Threshold Voltage	V _{GS(th)}	1	_	3	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance		_	30	44	mΩ	$V_{GS} = 10V, I_D = 4.3A$	
	R _{DS} (ON)	_	35	60	1115.2	$V_{GS} = 4.5V, I_D = 4A$	
Forward Transfer Admittance	Y _{fs}	_	4.5		S	$V_{DS} = 10V, I_D = 4.3A$	
Diode Forward Voltage	V _{SD}	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss	_	1287	_		$V_{DS} = 25V, V_{GS} = 0V$ f = 1.0MHz	
Output Capacitance	Coss	_	57	_	pF		
Reverse Transfer Capacitance	C _{rss}	_	44	_			
Gate Resistance	R _G	_	1.2	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge ($V_{GS} = 10V$)	Qg	_	22.4	_			
Total Gate Charge ($V_{GS} = 4.5V$)	Qg	_	10.4	_	nC	$V_{DS} = 30V, I_D = 4.3A$	
Gate-Source Charge	Q _{gs}	_	4.9	_	no		
Gate-Drain Charge	Q _{gd}	_	3.0	_			
Turn-On Delay Time	t _{D(on)}	_	6.6	_			
Turn-On Rise Time	tr	_	8.1	_	nS	$\label{eq:VGS} \begin{split} V_{GS} &= 10V, \ V_{DD} = 30V, \ R_{G} = 6\Omega, \\ I_{D} &= 4.3A \end{split}$	
Turn-Off Delay Time	t _{D(off)}	_	20.1	_	15		
Turn-Off Fall Time	t _f		4.0	_]		
Body Diode Reverse Recovery Time	t _{rr}		18		nS	I _S = 4.3A, dl/dt = 100A/µs	
Body Diode Reverse Recovery Charge	Q _{rr}	_	11.9	_	nC	I _S = 4.3A, dl/dt = 100A/µs	

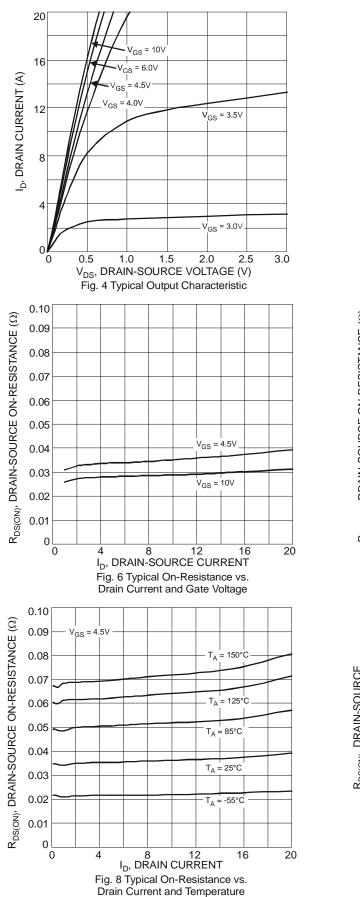
 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate. Notes:

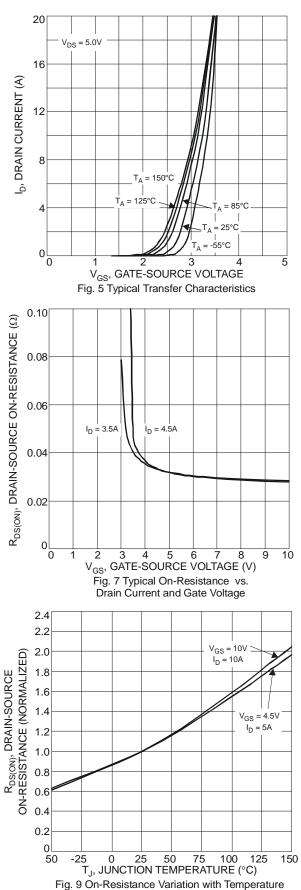
6. I_{AR} and E_{AR} rating are based on low frequency and duty cycles to keep $T_J = 25^{\circ}C$

7. Short duration pulse test used to minimize self-heating effect.

8. Guaranteed by design. Not subject to product testing.

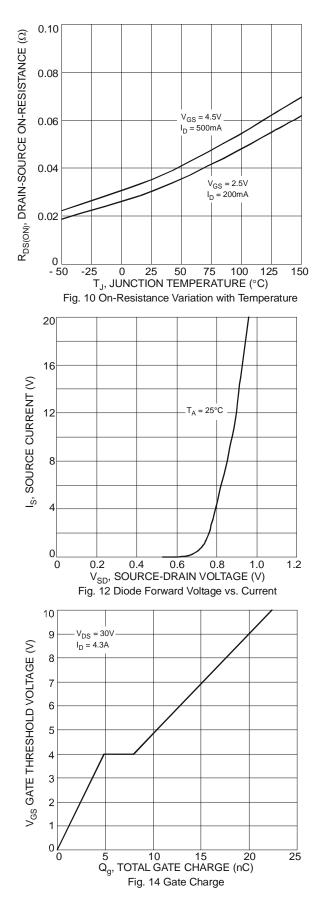


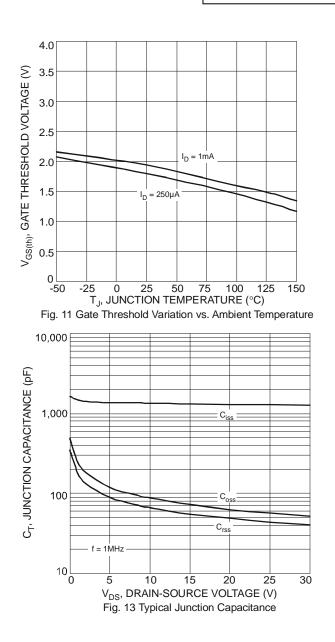




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Тур

2.90

2.80

1.60

0.95

1.90

_

0.25

4°

1.00

0.10

0.90

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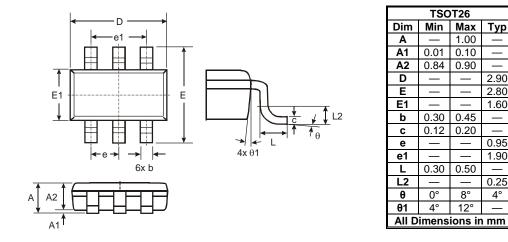
0.45

0.20

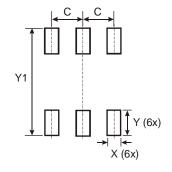
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12°

Package Outline Dimensions



Suggested Pad Layout



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199



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